

HIGH COMMUTATION TRIAC

<p>TO220-AB</p>	<table style="width: 100%; border: none;"> <tr> <td style="width: 50%;">On-State Current</td> <td style="width: 50%;">Gate Trigger Current</td> </tr> <tr> <td style="text-align: center;">16 Amp</td> <td style="text-align: center;">25 mA to 50 mA</td> </tr> <tr> <td colspan="2" style="text-align: center;">Off-State Voltage</td> </tr> <tr> <td colspan="2" style="text-align: center;">200 V ÷ 600 V</td> </tr> </table> <p style="margin-top: 20px;">This series of TRIACs uses a high performance PNPN technology.</p> <p>These parts are intended for general purpose AC switching applications with highly inductive loads.</p>	On-State Current	Gate Trigger Current	16 Amp	25 mA to 50 mA	Off-State Voltage		200 V ÷ 600 V	
On-State Current	Gate Trigger Current								
16 Amp	25 mA to 50 mA								
Off-State Voltage									
200 V ÷ 600 V									

Absolute Maximum Ratings, according to IEC publication No. 134

SYMBOL	PARAMETER	CONDITIONS	Min.	Max.	Unit
$I_{T(RMS)}$	RMS On-state Current	All Conduction Angle, $T_C = 100\text{ }^\circ\text{C}$	16		A
I_{TSM}	Non-repetitive On-State Current	Full Cycle, 60 Hz	170		A
I_{TSM}	Non-repetitive On-State Current	Full Cycle, 50 Hz	160		A
I^2t	Fusing Current	$t = 10\text{ ms}$, Half Cycle	150		A ² s
I_{GM}	Peak Gate Current	$20\text{ }\mu\text{s max.}$ $T_j = 125\text{ }^\circ\text{C}$		4	A
$P_{G(AV)}$	Average Gate Power Dissipation	$T_j = 125\text{ }^\circ\text{C}$		1	W
di/dt	Critical rate of rise of on-state current	$I_G = 2x I_{GT}$, $t_r = 100\text{ ns}$ $f = 120\text{ Hz}$, $T_j = 125\text{ }^\circ\text{C}$	50		A/ μs
T_j	Operating Temperature		-40	+125	$^\circ\text{C}$
T_{stg}	Storage Temperature		-40	+150	$^\circ\text{C}$

SYMBOL	PARAMETER	VOLTAGE			Unit
		B	D	M	
V_{DRM} V_{RRM}	Repetitive Peak Off State Voltage	200	400	600	V

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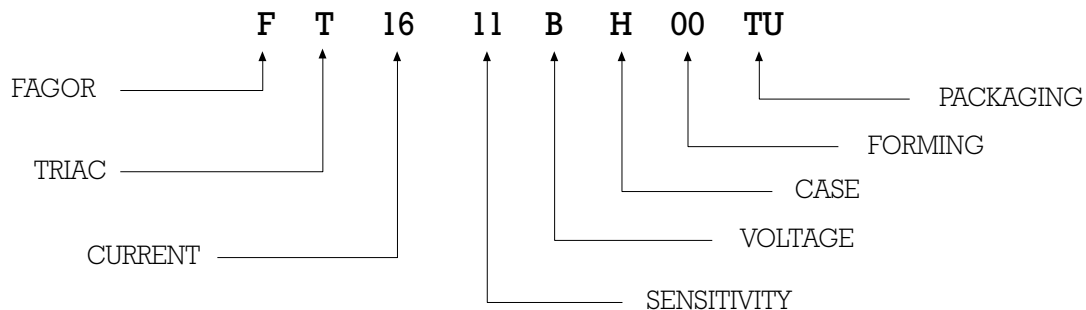
Electrical Characteristics

SYMBOL	PARAMETER	CONDITIONS	Quadrant		SENSITIVITY			Unit
					11	14	16	
$I_{CT}^{(1)}$	Gate Trigger Current	$V_D = 12 V_{DC}, R_L = 30 \Omega, T_j = 25^\circ C$	Q1÷Q3	MAX	25	35	50	mA
I_{DRM} / I_{RRM}	Off-State Leakage Current	$V_D = V_{DRM}, R_{GK} = 1K \Omega, T_j = 125^\circ C$ $V_R = V_{RRM}, T_j = 25^\circ C$		MAX	2			mA
				MAX	5			μA
$V_{to}^{(2)}$	Threshold Voltage	$T_j = 125^\circ C$		MAX	0.85			V
$R_d^{(2)}$	Dynamic Resistance	$T_j = 125^\circ C$		MAX	25			m
$V_{TM}^{(2)}$	On-state Voltage	$I_T = 22.5 \text{ Amp}, t_p = 380 \mu s, T_j = 25^\circ C$		MAX	1.55			V
V_{GT}	Gate Trigger Voltage	$V_D = 12 V_{DC}, R_L = 30 \Omega, T_j = 25^\circ C$	Q1÷Q3	MAX	1.3			V
V_{GD}	Gate Non Trigger Voltage	$V_D = V_{DRM}, R_L = 3.3K \Omega, T_j = 125^\circ C$	Q1÷Q3	MIN	0.2			V
$I_H^{(2)}$	Holding Current	$I_T = 100 \text{ mA}, \text{ Gate open}, T_j = 25^\circ C$		MAX	25	35	50	mA
I_L	Latching Current	$I_G = 1.2 I_{CT}, T_j = 25^\circ C$	Q1,Q3 Q2	MAX	40	50	70	mA
				MAX	50	60	80	
$dv / dt^{(2)}$	Critical Rate of Voltage Rise	$V_D = 0.67 \times V_{DRM}, \text{ Gate open}$ $T_j = 125^\circ C$		MIN	200	500	1000	V/ μs
$(dI/dt)_c^{(2)}$	Critical Rate of Current Rise	$(dv/dt)_c = 0.1 \text{ V}/\mu s, T_j = 125^\circ C$ $(dv/dt)_c = 10 \text{ V}/\mu s, T_j = 125^\circ C$ without snubber $T_j = 125^\circ C$		MIN	-	-	-	A/ms
				MIN	-	-	-	
				MIN	7.1	8.5	14	
$R_{th(j-c)}$	Thermal Resistance Junction-Case	for AC 360° conduction angle			1.2			$^\circ C/W$
$R_{th(j-a)}$	Thermal Resistance Junction-Ambient				60			$^\circ C/W$

(1) Minimum I_{CT} is guaranteed at 5% of I_{CT} max.

(2) For either polarity of electrode MT2 voltage with reference to electrode MT1.

PART NUMBER INFORMATION



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Fig. 1: Maximum power dissipation versus RMS on-state current (full cycle).

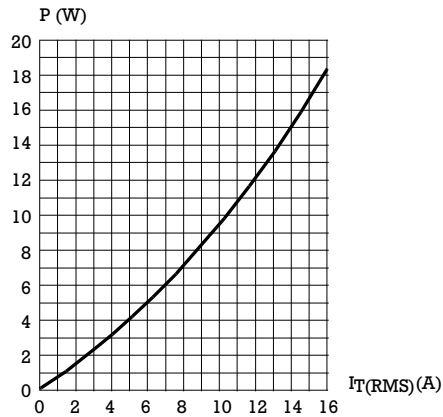


Fig. 3: Relative variation of thermal impedance versus pulse duration.

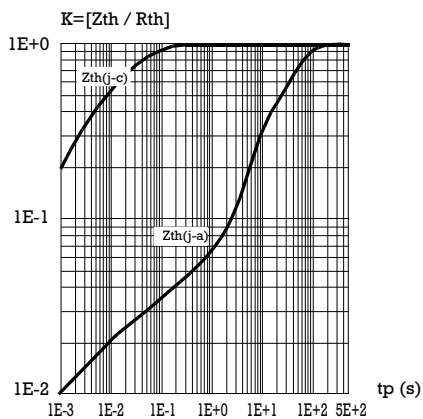


Fig. 5: Surge peak on-state current versus number of cycles.

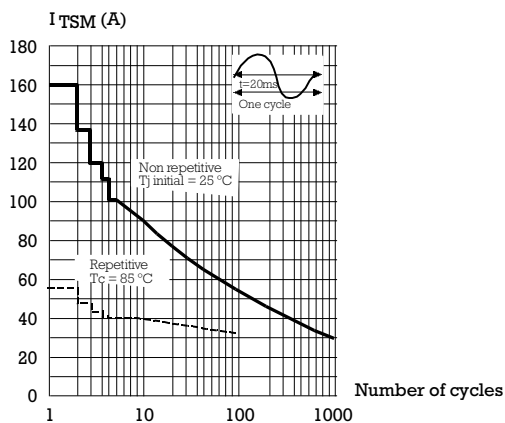


Fig. 2: RMS on-state current versus case temperature (full cycle).

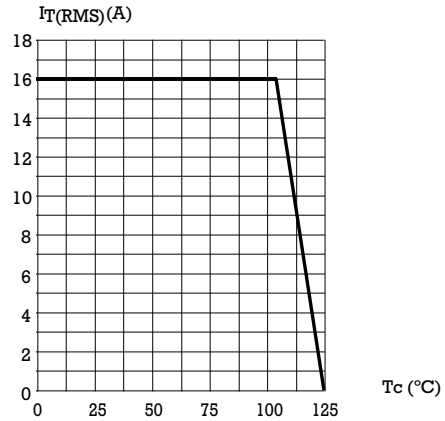


Fig. 4: On-state characteristics (maximum values)

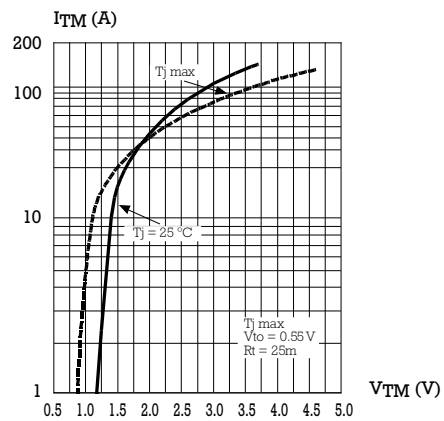
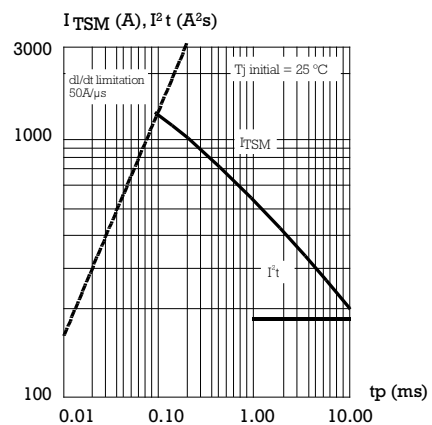


Fig. 6: Non-repetitive surge peak on-state current for a sinusoidal pulse with width $t_p < 10\text{ms}$, and corresponding value of I^2t .



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Fig. 7: Relative variation of gate trigger current, holding current and latching versus junction temperature (typical values)

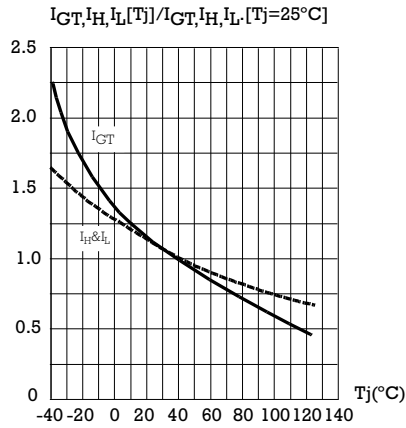
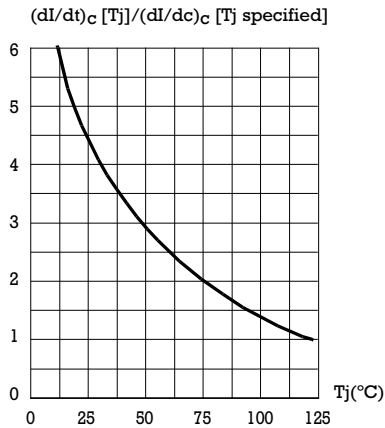


Fig. 8: Relative variation of critical rate of decrease of main current versus junction temperature



PACKAGE MECHANICAL DATA TO-220AB (Plastic)

